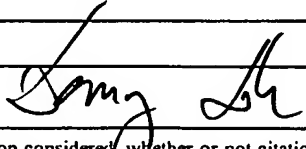


Form PTO-1449 (REV. 1/06)		US Dept. of Commerce <b>PATENT &amp; TRADEMARK OFFICE</b>		ATTY DOCKET NO. 118118		APPLICATION NO. 10/736,644	
<div style="display: flex; align-items: center;"> <div style="border: 2px solid black; border-radius: 50%; padding: 10px; text-align: center; margin-right: 10px;">             OIPE              MAR 21 2006              PATENT &amp; TRADEMARK OFFICE           </div> <div> <b>INFORMATION DISCLOSURE STATEMENT</b>              (Use several sheets if necessary)           </div> </div>				APPLICANT(S) Hiroyuki OGI			
				FILING DATE December 17, 2003		GROUP 2834	
<b>U.S. PATENT DOCUMENTS</b>							
Examiner Initials	Cite No.	Document Number	Date	Name			
K	1	5,949,166	9/1999	Ooiwa et al.			
<b>FOREIGN PATENT DOCUMENTS</b>							
Examiner Initials	Cite No.	Document Number	Date	Country	With English Abstract	With English Translation	
	2	CN 1173738	2/1998	China			
	3	CN 1084876	5/2002	China			
<b>OTHER DOCUMENTS</b>							
Examiner Initials	Cite No.	(Including Author, Title, Date, Pertinent Pages, etc.)					
EXAMINER					DATE CONSIDERED 5/23/06		
Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

Date: March 21, 2006

Form PTO-1449 (REV. 1/06)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 118118		APPLICATION NO. 10/736,644	
INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)				APPLICANT(S) Hiroyuki OGI		GROUP 2834	
				FILING DATE December 17, 2003			
U.S. PATENT DOCUMENTS							
Examiner Initials	Cite No.	Document Number	Date	Name			
DL	1	3,078,409	2/1963	Bertsche, Jr. et al.			
DL	2	4,554,574	11/1985	Wright			
DL	3	2002/0114177 A1	8/2002	DeNardis			
FOREIGN PATENT DOCUMENTS							
Examiner Initials	Cite No.	Document Number	Date	Country	With English Abstract	With English Translation	
DL	4	2 057 763 A	4/1981	Great Britain			
OTHER DOCUMENTS							
Examiner Initials	Cite No.	(Including Author, Title, Date, Pertinent Pages, etc.)					
EXAMINER						DATE CONSIDERED 3/23/06	
Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

Date: February 10, 2006